QIE & potential use in EB VFE



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Introduction

• QIE overview

- operation, response, performance, usage in HCAL, radiation tolerance
- Considerations for **EB usage**:
 - many EB channels \rightarrow available space on detector
 - excellent EB resolution \rightarrow digitization precision and dynamic range
 - timing requirements
 - radiation tolerance

• Summary

QIE11 overview

- Gated charge integrator
 - operation tested from 40–100 MHz
- 17-bit dynamic range with 8-bit readout (emphasis on economy of bits)
 - 4 ranges and 6-bit ADC
- 6-bit TDC (500 ps resolution)
- 350 nm SiGe BiCMOS process (AMS)
 - sufficient TID/neutron tolerance for HCAL barrel front-end
 - potential advantage for SEE
 - 5V @ 40 mA analog, 3.3V @ 35 mA digital (320 mW total)
- Internal charge injection
- Internal clock phase adjustment
- Input current shunt allows tuning of photosensor gain.

3.2mm

10mm

QIE history

- Designed by Tom Zimmerman since before 1995.
 - A short history of development:
 - 1989: Originally conceived by Bill Foster for **SDC @ SSC**
 - 1995: 1st fully-functional chip designed by <u>Tom Zimmerman</u> for the **KTeV experiment @ FNAL**
 - 2 μm Orbit "Bi-CMOS", 3000 ch.
 - 1996: Front-end for calorimeters of CDF @ FNAL
 - 2 μm Orbit "Bi-CMOS", 10,000 ch.
 - 2002: Front-end for MINOS Near Detector @ FNAL
 - 2 μm Orbit "Bi-CMOS", 10,000 ch.
 - 2003: Front-end for CMS HCAL @ CERN
 - 0.8 μm AMS BiCMOS, 10,000 ch.
 - 2013: Front-end for CMS HCAL upgrade, and a *candidate* for ATLAS TileCAL upgrade
 - 0.35 μ m AMS SiGe, 17,000 ch. \rightarrow 27,000 ch.









Joint Development





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QIE11 operation

- Receive charge from photosensor
- **Split** current into 4 logarithmically weighted ranges
- Integrate currents on separate capacitors
- Select lowest range capacitor that is not saturated
- **Digitize** voltage on selected capacitor with FADC



QIE11 operation (2)

- **Split** ratios: 16, 4, 2, 1, 1 (for TDC)
- Integration capacitor ratios: 1, 2, 8, 32
- Select
- **ADC** sub-range ratios: 3, 6, 12, 24



QIE11 response



LSB = 3 fC Maximum ~ 350 pC

ADC Code



QIE11 performance

- Tested ~200 quantities for 12k QIE11 in April 2016 using ASIC test robot.
- Yield for basic functionality is ~98%.
- Yield for uniformity requirements is ~85%.
- Response variation acheived by precision of bipolar current splitters ~1.5%.



Usage on HCAL frontend card

- Microsemi ProASIC3 FPGA
 - slow control via I2C, Igloo programming
- CERN VTTx (not stuffed in photo)

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- data transmission
- Microsemi Igloo2 FPGA ^{**}
 - alignment/clock, serialization, formatting, encoding
- 6 **QIE11** (6 on other side) *****
 - signal digitization



- LVDS
- ----- Digital Ground (dgnd)
- Analog Ground (agnd)
- •••••• 5V power supply line (avdd)
- •••••• 3.3V power supply line (vdd, vddFE, dvdd)



Recommended PCB layout for QIE11

HCAL radiation tolerance requirements

	TID (krad)	1 MeV neutron (cm ⁻²)	>20 MeV hadron (cm ⁻²)
HB	3.1±0.7	(1.1±0.1)E+12	(2.0±0.3)E+11
HE	0.9±0.1	(9±2)E+10	(1.6±0.6)E+10
HF	4.1±2.7	(7±0.7)E+11	(1.8±0.3)E+11



Potential radiation effects

Cumulative effects

- Total ionizing dose (TID) in CMOS and SiGe bipolar components.
- **Displacement damage (DD)** in SiGe bipolar components.

Single event effects (SEE)

- **Digital SEU** in CMOS.
- Analog SEU in current splitters, integrators, etc.
- **Catastrophic SEE**: burnout (SEBO), gate rupture (SEGR), and latchup (SEL).
- We studied these effects simultaneously with 230 MeV protons for which 1e11/cm2 fluence ~ 5.8 krad TID in silicon.

Chip Monitoring

- 1) Operate chip in beam and **count five error types**:
- Capacitor ID (should cycle 0,1,2,3)
- Exponent errors (should be 0)
- TDC errors (should be 63)
- DLL NoLock (should be locked)
- TDC discriminator (should be low)
- change in rad hard shadow register

Zero occurences, as expected

- 2) Use these raw counts to determine expected **SEE rate** assuming:
- 7000 HE channels
- 1.6e10/cm2 fluence for 20 MeV hadrons
- integrated luminosity of 3000/fb
- instantaneous luminosity of 5e34/cm2/s
- 3) Monitor **pedestal** vs. TID and nucleon fluence.
- 4) Monitor **response** vs. nucleon fluence.

Test configuration

- Tested QIE10 in 230
 MeV proton beam at Central Dupage Hospital near Fermilab
- Operated chip with full power, clock, and 40MHz readout.
- Three different days/ chips: 10-Dec-14, 19-Dec-14, 04-Mar-14
- Flux ~5x10⁹ protons/ cm²/s
- Dose rate ~300 rad/s



SEE: Exponent error rate

- One exponent error every ~minute on entire detector (16k channels).
- Frontend runs without interruption — zero intervention required.
- Uncorrelated with physics events.
- Potential trigger deadtime and signal inefficiency is 1e-9.
- Acceptable for HCAL



SEE: TDC error rate

HB=3krad TID in Si [krad] 200 100 300 400 0, 500 Hz] One TDC error every 10 04-Mar-14 TDC error rate [10⁻³ 10 minutes hours on entire HBHE 10-Dec-13 detector. 19-Dec-13 8 • Acceptable for HCAL 6 O **50** 100 0 Fluence [10¹¹ protons/cm²] $HB=2x10^{12}/cm^{2}$

SEE: CapID error rate

- On Dec19, CapIDs stopped rotating at about 200 krad (40e11/cm²), but recovered after QIE reset.
- QIE reset occurs every orbit in normal operations.
- Acceptable for HCAL



TID: DLL NoLock rate

- Observed cumulative damage failure mode: DLL loses ability to lock
- Anneals in 10 days at room temperature → TID effect
 - not displacement damage from neutron fluence
- Occurs at **250 krad** or later.
- Acceptable for HCAL



TID : Pedestal drift

- Observed pedestal drift
- Anneals in 10 days at room temperature → TID effect (not DD effect)
- Occurs at **150 krad** or later.
- Acceptable for HCAL



Analog SEU at CERN CHARM facility

http://charm.web.cern.ch/CHARM/

- Long run shows order 10⁻⁸ effects
- Rates of 0.5 Hz to 0.006 Hz uncorrelated with real physics events.
- Acceptable for HCAL



Considerations for EB

 M. Dejardin*: Charge integration might outperform pulse shaping for mitigating effect of APD dark current and out-of-time pileup associated with HL-LHC.
 * DN-2015-14

> https://indico.cern.ch/event/371835/contributions/881679/ attachments/1150997/1652502/MD Upgrade 20150908.pdf

Important considerations

- More channels / physical space on detector
- EB resolution and dynamic range >> HCAL resolution and dynamic range
- more precise timing requirements
- higher radiation tolerance requirement





Physical footprint

- 64-pin thin quad flat package is 12x12 mm²
- QIE die size is 3.2 x 3.2 mm²
 - Make better use of space with 4–6 channels chip = "quad-QIE" chip.
 - Developed for QIE11, but not needed.

- 20 pins devoted to LVDS output: 16 data, 2 clock, 2 discriminator.
- QIE13: on-chip serialization reduces output pins by factor by 2-4.
 - Implemented for QIE9 (BTeV) but not used.

Not a problem for EB



Resolution and dynamic range



• Plot from Marc Dejardin from Ischia matches proposal for QIE13 for Shashlik from 2013 ... next slide ...

Resolution and dynamic range (2)

	QIE11	QIE13
ADC bits	6	8
ranges	4	4
sub-ranges	4	5
E _{max} [TeV]	1.1	1.5
Gain [fC/GeV]	313	380
LSB [MeV]	10*	8
LSB [fC]	3	3
dyn range [bit]	17	18**
% error in tail	1.5	0.25**



- QIE13 specs for Shashlik
- Add 2 bits to ADC
 - room on chip is sufficient

Not a problem for EB

Timing

Require R C 37 ns resolution for reasonably sized signals.

QIE11 6-bit TDC gives 500 ps resolution over full 25ns bucket using 2 GHz
 DLL.

• 30ps requires 10-bit TDC for 40 MHz operation and ~40 GHz DLL.

• **Technically feasible?** Probably not with current design.

Is this data volume reasonable with zero suppression on front end?

Use restricted range for valid codes? Do we need 30ps resolution for full 25ns 200 225 250 275 300 325 350 375 400 DUCKetime [ns]

 MD shows 100 ps resolution for QIE-like GQI (20uA dark current and 50 GeV signals) using energy measurement with knowledge of pulse shape.
 GQI 25 ns CRR04B energy resolution CRRC 19 ns CRR04B efits of GQI lost if CRRC 31 ns CRR04B fits of GQI lost if CRRC 31 ns CRR04B fits of GQI lost if CRRC 31 ns CRRC 43 ns 0 5 10 phase [ns]

GQI 25 ns CRRC 13 ns

CRRC 19 ns CRRC 25 ns CRRC 31 ns



EB radiation tolerance requirement

	TID	1 MeV neutron	>20 MeV hadron
	(krad)	(cm ⁻²)	(cm ⁻²)
EB	1000	1E+14	not considered



- QIE tested to 250 krad and 1e13 1MeV-neutrons/cm^{2.}
 - TID effects could be dose rate dependent.
- More studies required for EB use biggest concern for QIE.

Summary

- **QIE13 charge digitizing ASIC** would be well suited to EB for **resolution** and **physical size**.
- Radiation tolerance requirements for EB are challenging
 - QIE11 are tested to 1e13 1MeV-equivalent neutrons / cm²
 - Problems observed around TID of 250 krad.
 - Behavior of electronics in high current beam difficult to interpret more study needed.
- Timing precision requirements for EB are challenging
 - Simple TDC requires 10 bits, but more creative options possible.
 - Timing from energy distribution in 25ns bins has ~100ps resolution problem with GQI in general, not QIE.

Additional Material

QIE11 overview (3)

